

SSC8129GS1

P-Channel Enhancement Mode MOSFET

VDS	VGS	RDSON Typ.	ID	
-20V	±12V	11mR@-4V5	454	
		13mR@-2V5	-15A	

> Description

This device is produced with high cell density, DMOS trench technology, which is especially used to minimize on-state resistance. This device is particularly suited for low voltage power management requiring a wild range of given voltage ratings(4.5V-25V) such as load switch and battery protection.

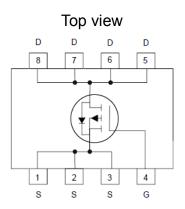
> Applications

- Load Switch
- NB battery
- DCDC conversion

> Ordering Information

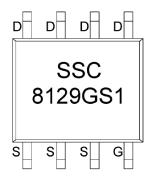
Device	Package	Shipping
SSC8129GS1	SOP8	2500/Reel

> Pin configuration





SOP8



Marking



> **Absolute Maximum Ratings**(T_A=25°C unless otherwise noted)

Symbol	Parameter	Ratings	Unit	
V _{DSS}	Drain-to-Source Voltage	-20	V	
V _{GSS}	Gate-to-Source Voltage	±12	V	
I _D	Continuous Drain Current ^a	-15	А	
I _{DM}	Pulsed Drain Current ^b	-41	А	
P _D	Power Dissipation ^c	5.5	W	
P _{DSM}	Power Dissipation ^a	2.5	W	
TJ	Operation junction temperature	-55 to 150	°C	
T _{STG}	Storage temperature range -55 to 150		°C	

➤ Thermal Resistance Ratings(T_A=25°C unless otherwise noted)

Symbol	Parameter	Typical	Maximum	Unit
$R_{ extsf{ heta}JA}$	Junction-to-Ambient Thermal Resistance ^a		55	°C/W
$R_{ extsf{ heta}JC}$	R _{0JC} Junction-to-Case Thermal Resistance		25	C/ W

Note:

- a. The value of R_{θJA} is measured with the device mounted on 1 in² FR-4 board with 2oz.copper,in a still air environment with T_A=25C°. The value in any given application depends on the user is specific board design. The current rating is based on the t ≤ 10s thermal resistance rating.
- b. Repetitive rating, pulse width limited by junction temperature.
- c. The power dissipation P_D is based on T_{J(MAX)}=150°C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heat sinking is used.

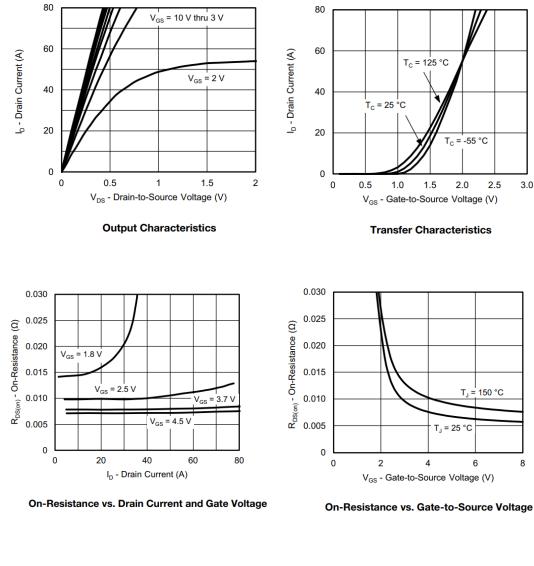


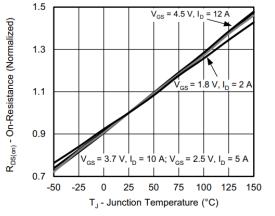
Electronics Characteristics(T_A=25°C unless otherwise noted)

Symbol	Parameter	Test Conditions	Min	Тур.	Мах	Unit
V(BR)DSS	Drain-Source Breakdown Voltage	VGS=0V , ID=-250uA	-20			V
Vgs (th)	Gate Threshold Voltage	VDS=VGS , ID=-250uA	-0.5	-0.7	-1	V
_	Drain-Source On-	VGS=-4.5V , ID=-10A		11	13	mR
RDS(on)	Resistance	VGS=-2.5V , ID=-7A		13	16	
Idss	Zero Gate Voltage Drain Current	VDS=-16V , VGS=0V			-1	uA
lgss	Gate-Source leak current	VGS=±12V , VDS=0V			±100	nA
GFS	Trans conductance	VDS=-5V , ID=-10A		18		S
Vsd	Forward Voltage	VGS=0V , IS=-2.3A		-0.7	-1.3	V
Ciss	Input Capacitance	VDS=-15V , VGS=0V, f=1MHz		1820		
Coss	Output Capacitance			489		pF
Crss	Reverse Transfer Capacitance			663		
Qg	Total Gate charge			22		
Qgs	Gate to Source charge	VGS=-4.5V , VDS=-15V, ID=-7A		2.5		nC
Qgd	Gate to Drain charge			6		
T _{D(ON)}	Turn-on delay time	VGS=-10V,		11		
Tr	Rise time			22		20
T _{D(OFF)}	Turn-off delay time	VDS=-15V, RL=1.5R, RG=3R		51		ns
Tf	Fall time	NG-3K		24		

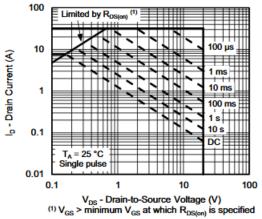


> Typical Characteristics(T_A=25°C unless otherwise noted)





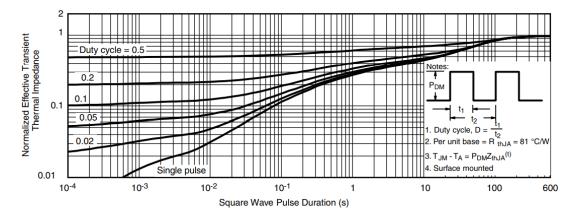
On-Resistance vs. Junction Temperature



Safe Operating Area, Junction-to-Ambient



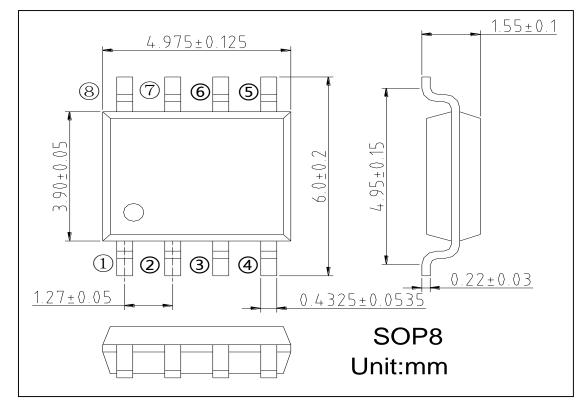
SSC8129GS1



Normalized Thermal Transient Impedance, Junction-to-Ambient



> Package Information



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